FAIRCHILD™

January 2015

FDMC86160ET100

N-Channel Shielded Gate PowerTrench® MOSFET
100 V, 43 A, 14 mΩ

Features

- Extended T_J rating to 175°C

- Shielded Gate MOSFET Technology

- Max $r_{DS(on)}$ = 14 mΩ at V_{GS} = 10 V, I_D = 9 A

- Max $r_{DS(on)}$ = 23 mΩ at V_{GS} = 6 V, I_D = 7 A

- High performance technology for extremely low $r_{DS(on)}$

- Termination is Lead-free and RoHS Compliant

General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance. This device is well suited for applications where ulta low $R_{DS\ (on)}$ is required in small spaces such as High performance VRM, POL and orring functions.

Applications

- Bridge Topologies

- Synchronous Rectifier

Pin 1

Top   **Bottom**

Power 33
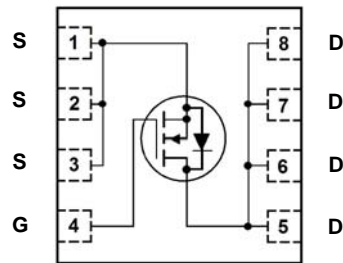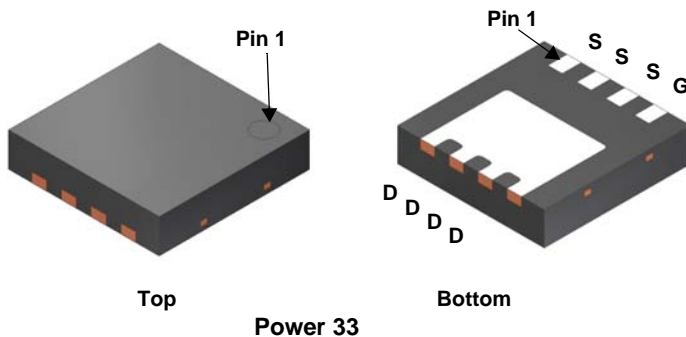
MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			100	V
V_{GS}	Gate to Source Voltage			±20	V
I_D	Drain Current -Continuous	T_C = 25 °C	(Note 5)	43	A
	-Continuous	T_C = 100 °C	(Note 5)	31	
	-Continuous	T_A = 25 °C	(Note 1a)	9	
	-Pulsed		(Note 4)	204	
E_{AS}	Single Pulse Avalanche Energy		(Note 3)	181	mJ
P_D	Power Dissipation	T_C = 25 °C		65	W
	Power Dissipation	T_A = 25 °C	(Note 1a)	2.8	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		(Note 1)	2.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		(Note 1a)	53	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86160ET	FDMC86160ET100	Power33	13 "	12 mm	3000 units

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Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V	100			V
$\dfrac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		73		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 80 V, V_{GS} = 0 V			1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V			±100	nA
On Characteristics						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250 μA	2	2.9	4	V
$\dfrac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		-9		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10 V, I_D = 9 A		11.2	14	mΩ
		V_{GS} = 6 V, I_D = 7 A		16	23	
		V_{GS} = 10 V, I_D = 9 A, T_J = 125 °C		21	26	
g_{FS}	Forward Transconductance	V_{DD} = 10 V, I_D = 9 A		43		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 50 V, V_{GS} = 0 V, f = 1 MHz		968	1290	pF
C_{oss}	Output Capacitance			241	320	pF
C_{rss}	Reverse Transfer Capacitance			11	20	pF
R_g	Gate Resistance		0.1	0.6	2.5	Ω
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 50 V, I_D = 9 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		9.7	19	ns
t_r	Rise Time			3.6	10	ns
$t_{d(off)}$	Turn-Off Delay Time			16	30	ns
t_f	Fall Time			3.4	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to 10 V		15	22	nC
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to 6 V, V_{DD} = 50 V, I_D = 9 A		9.8	15	nC
Q_{gs}	Total Gate Charge			4.4		nC
Q_{gd}	Gate to Drain "Miller" Charge			3.5		nC
Drain-Source Diode Characteristics						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 9 A (Note 2)		0.79	1.3	V
		V_{GS} = 0 V, I_S = 1.9 A (Note 2)		0.72	1.2	V
t_{rr}	Reverse Recovery Time	I_F = 9 A, di/dt = 100 A/μs		47	75	ns
Q_{rr}	Reverse Recovery Charge			45	73	nC

Notes:
1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.
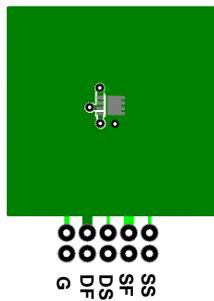
53 °C/W when mounted on a
a. 1 in² pad of 2 oz copper
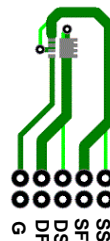
125 °C/W when mounted on
b. a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

3. E_{AS} of 181 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 11 A, V_{DD} = 100 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 35 A.

4. Pulsed Id please refer to Fig 11 SOA graph for more details.

5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

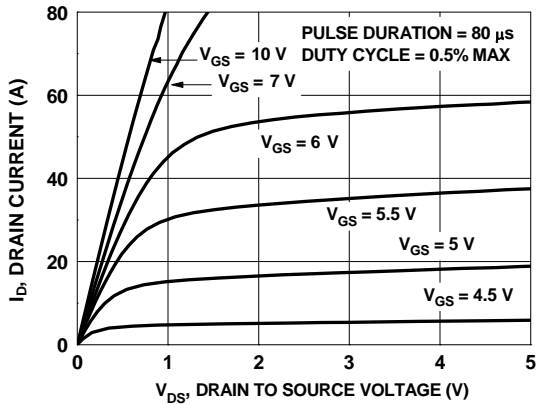## Typical Characteristics T_J = 25 °C unless otherwise noted

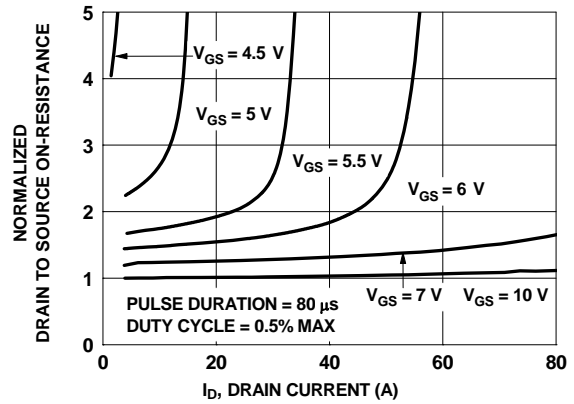Figure 1. On-Region Characteristics

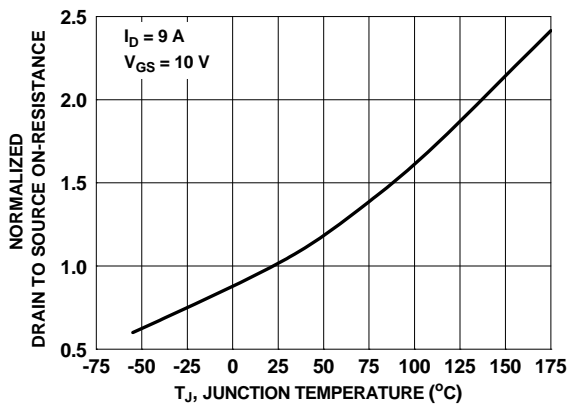Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

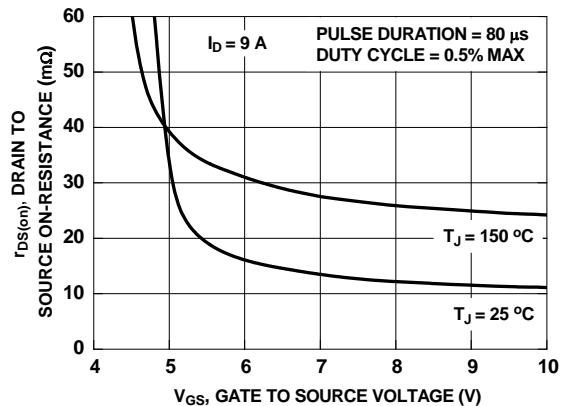Figure 3. Normalized On-Resistance vs Junction Temperature

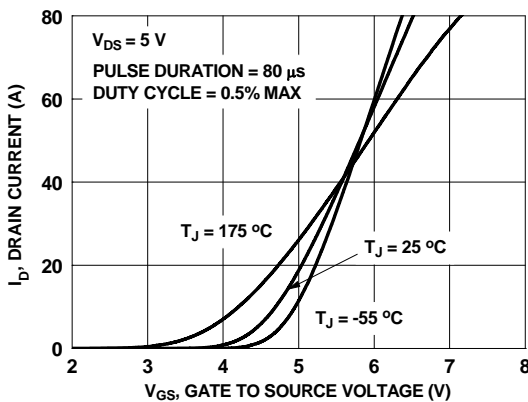Figure 4. On-Resistance vs Gate to Source Voltage
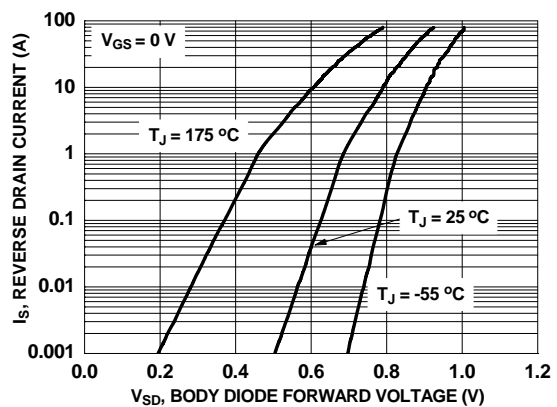

Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs Source Current

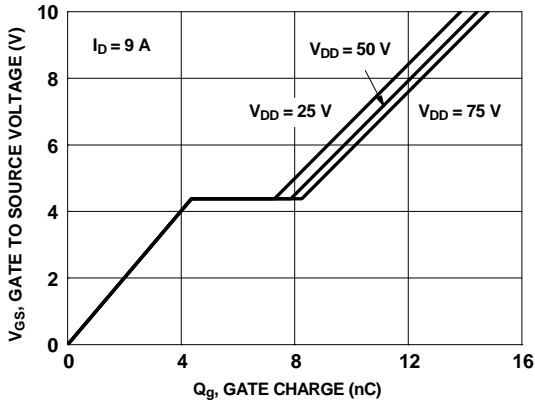## Typical Characteristics T_J = 25 °C unless otherwise noted

Figure 7. Gate Charge Characteristics
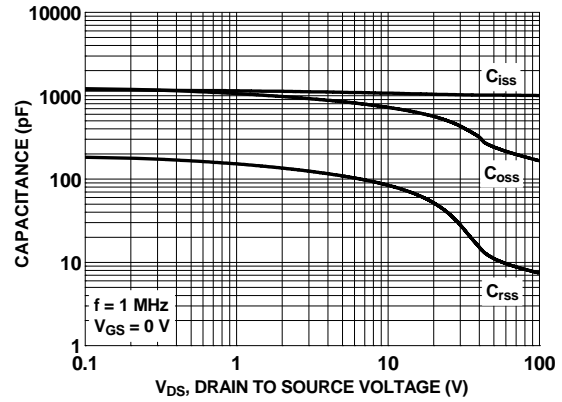
Figure 8. Capacitance vs Drain to Source Voltage
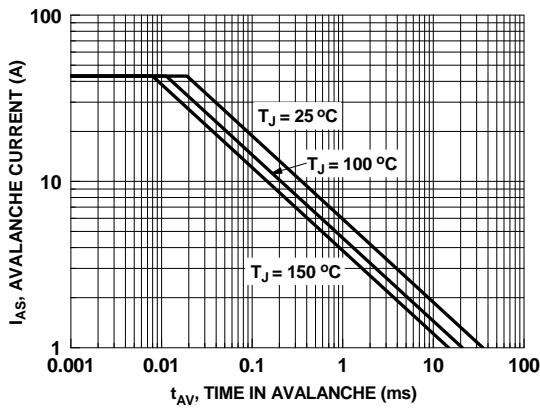
Figure 9. Unclamped Inductive Switching Capability
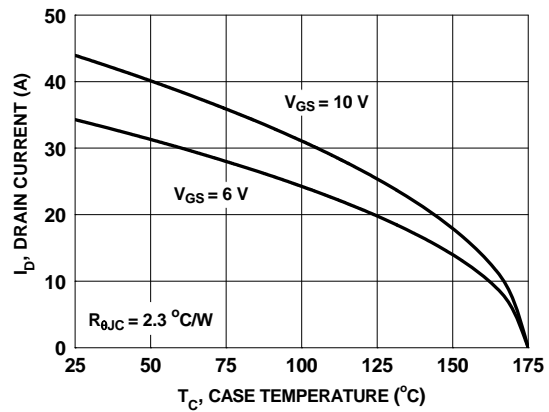
Figure 10. Maximum Continuous Drain Current vs Case Temperature
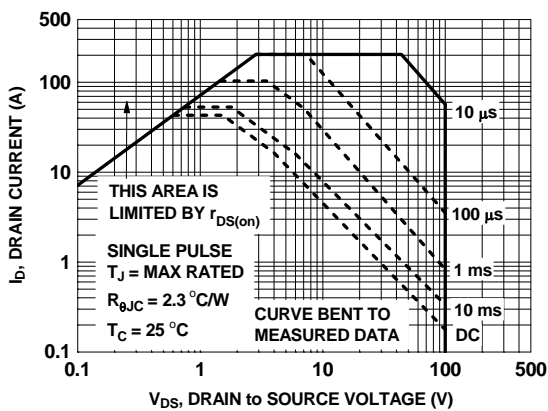
Figure 11. Forward Bias Safe Operating Area
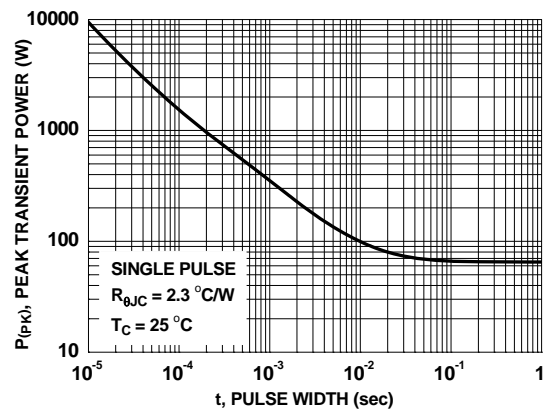
Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted
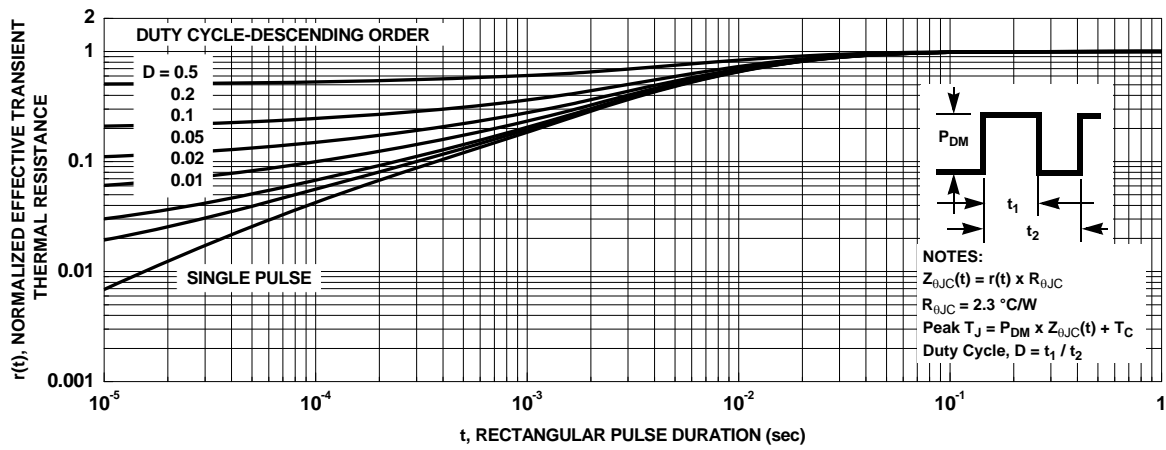
Figure 13. Junction-to-Case Transient Thermal Response Curve

A

B

3.40
3.20
PKG ℄

8   5

PKG ℄

3.40
3.20

PIN 1
INDICATOR

1   4

SEE
DETAIL A

2.37 MIN

SYM ℄

(0.45)   8   SYM ℄   5

(0.40)

PKG ℄

(0.65)

2.15 MIN

0.70 MIN

1   4

0.65

1.95

0.42 MIN
(8X)
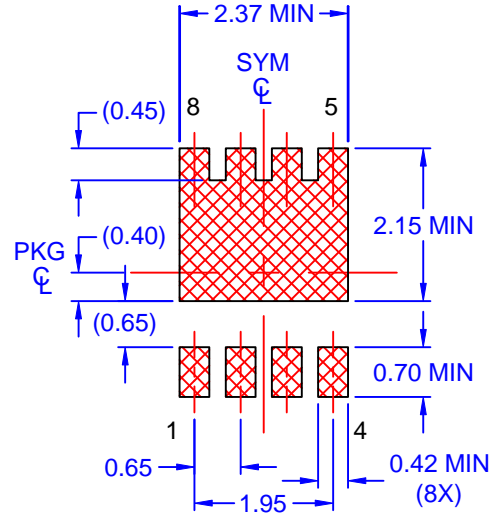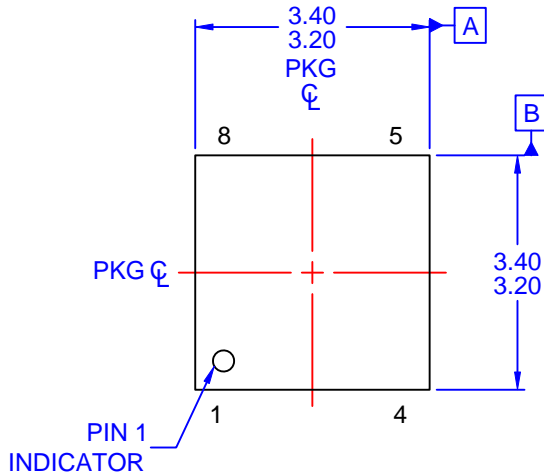
LAND PATTERN
RECOMMENDATION

⊕ | 0.10 | C | A | B

0.37
0.27 (8X)

1.95

0.65

1   4

0.50
0.30

PKG ℄

2.05
1.85

(0.34)   8   5   (0.33) TYP

(0.52 TYP)   (2.27)
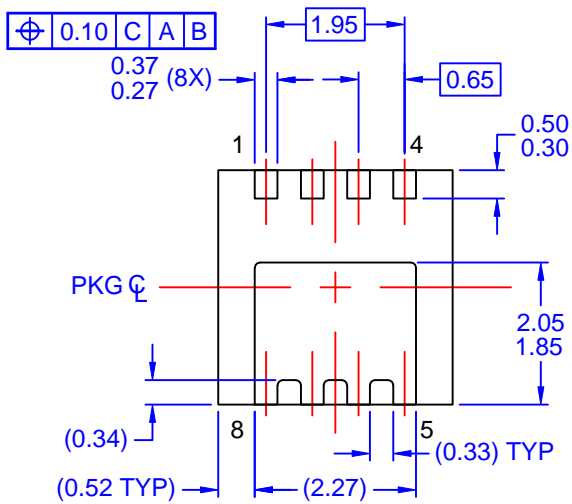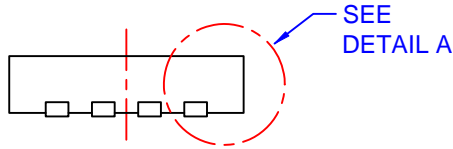
NOTES: UNLESS OTHERWISE SPECIFIED

A) PACKAGE STANDARD REFERENCE:
   JEDEC MO-240, ISSUE A, VAR. BA,
   DATED OCTOBER 2002.
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE BURRS
   OR MOLD FLASH. MOLD FLASH OR
   BURRS DOES NOT EXCEED 0.10MM.
D) DIMENSIONING AND TOLERANCING PER
   ASME Y14.5M-1994.
E) DRAWING FILE NAME: PQFN08HREV1

// | 0.10 | C

0.80
0.70

⌒ | 0.08 | C

0.05
0.00

0.25
0.15

C

SEATING
PLANE

DETAIL A
SCALE: 2X

PUBLICATION ORDERING INFORMATION
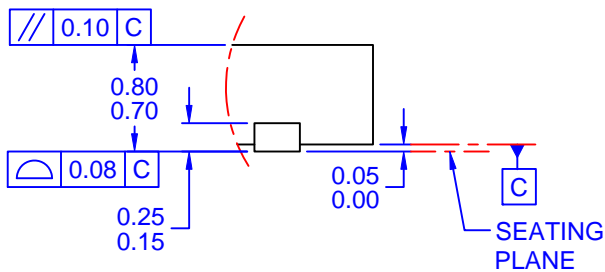
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